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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO	
09/811,660	03/19/2001	Akiteru Takatsuka	36856.447	36856.447 9407	
759	90 05/07/2	4	EXAMINER		
Keating & Ber			DOUGHERTY, THOMAS M		
10400 Éaton Place, Suite 312 Fairfax, VA 22030			ART UNIT	PAPER NUMBER	
			2834		

DATE MAILED: 05/07/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

	Applica	ation No.	Applicant(s)	_			
	09/811		TAKATSUKA ET AL.				
Office Action Summary		Examiner Art Unit					
•		s M. Dougherty	2834	pu)			
The MAILING DATE of this com	ı			ess			
Period for Reply			•				
A SHORTENED STATUTORY PERIO THE MAILING DATE OF THIS COMM - Extensions of time may be available under the provi- after SIX (6) MONTHS from the mailing date of this of If the period for reply specified above is less than thi If NO period for reply is specified above, the maximut - Failure to reply within the set or extended period for Any reply received by the Office later than three more earned patent term adjustment. See 37 CFR 1.704(UNICATION. sions of 37 CFR 1.136(a). In no communication. rty (30) days, a reply within the s im statutory period will apply and reply will, by statute, cause the a oths after the mailing date of this	event, however, may a reply lestatutory minimum of thirty (30 d will expire SIX (6) MONTHS application to become ABAND	be timely filed) days will be considered timely, from the mailing date of this commonED (35 U.S.C. § 133).	nunication.			
Status							
1) Responsive to communication(s) filed on 25 March 200	<u>)4</u> .					
2a) This action is FINAL.	2b)⊠ This action is						
3) Since this application is in condition for allowance except for formal matters, prosecution as to the merit closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.							
						Disposition of Claims	
4) Claim(s) 1-24 is/are pending in the	ne application.						
	4a) Of the above claim(s) is/are withdrawn from consideration.						
5) Claim(s) is/are allowed.							
6)⊠ Claim(s) <u>1-24</u> is/are rejected.							
7) Claim(s) is/are objected to) .						
8) Claim(s) are subject to re-	striction and/or election	n requirement.					
Application Papers							
9)☐ The specification is objected to b	y the Examiner.						
10)⊠ The drawing(s) filed on <u>13 June 2</u>		pted or b)☐ objected	d to by the Examiner.				
Applicant may not request that any				•			
Replacement drawing sheet(s) inclu	ding the correction is requ	uired if the drawing(s) is	s objected to. See 37 CFR	1.121(d).			
11)☐ The oath or declaration is objected	ed to by the Examiner.	Note the attached Of	fice Action or form PTO	-152.			
Priority under 35 U.S.C. § 119							
12)⊠ Acknowledgment is made of a cla	aim for foreign priority (under 35 U.S.C. § 11	9(a)-(d) or (f).				
a)⊠ All b)□ Some * c)□ None c		_					
1. Certified copies of the prior	rity documents have be	een received.					
2. Certified copies of the prior	rity documents have be	een received in Appli	cation No				
Copies of the certified cop	ies of the priority docur	ments have been rec	eived in this National St	age			
application from the Intern	•						
* See the attached detailed Office a	ction for a list of the ce	rtified copies not rec	eived.				
Attachment(s)							
1) Notice of References Cited (PTO-892)			mary (PTO-413)				
 2) Notice of Draftsperson's Patent Drawing Revie 3) Information Disclosure Statement(s) (PTO-144 		5) Notice of Inform	ail Date nal Patent Application (PTO-1:	52)			
Paper No(s)/Mail Date		6) Other:	· · · · · · · · · · · · · · · · · · ·				

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DETAILED ACTION

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1-3, 7-9, 13-15 and 19-21 are rejected under 35 U.S.C. 103(a) as being unpatentable over Sato et al. (US 5,424,602) in view of Lejeune (US 6,269,326). Sato shows (figs. 38A-D) a method for selecting a piezoelectric transformer having a desired characteristic, comprising the steps of: connecting a primary-side driving section of a piezoelectric transformer (TR) to a high-frequency generator (f) while leaving a secondary-side generating section thereof in an open state (e.g. figs. 38B, 38D) or in a short circuited state (e.g. 38A, 38C); causing said high-frequency generator to sequentially generate and weep a high-frequency signal over a predetermined frequency range (4.58 MHz to 5.08Mhz); measuring a resonant frequency (e.g. 1.835 MHz) or a resonant resistance (1.38 ohms) or both from an input-impedance-versusfrequency characteristic of the piezoelectric transformer (TR); selecting the piezoelectric transformer (TR) based on the value of the measured resonant frequency. The transformer in every figure is in an isolated state in which it is not mounted on a mounting substrate. Only the input-impedance-versus-frequency characteristic piezoelectric transformer is measured. Sato further shows a completing of the manufacturing of the piezoelectric transformer in figures 30(A) and 30(B). Note in these

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figures that the transformer is placed on a substrate and connected to it via lands (60a), further a cap (103) is placed on the device. In contradistinction to the applicants' contention in the REMARKS/ARGUMENTS that Sato et al. "clearly fails to teach or suggest the step of 'completing the manufacturing of the piezoelectric transformer after the steps of selecting and rejecting' " is thus incorrect. The Applicants' further contend that Sato merely measures the characteristics of the piezoelectric transformer after the piezoelectric transformer has been manufactured. However, *in arguendo*, if that is correct, the figures relied upon regarding this, 38A-D, still show the testing of the device before it is mounted, thus a clear suggestion is made to do so.

Lejeune shows a testing procedure for electronic components in his figure 2 and he notes at col. 2, lines 25-27, that measured values are compared with typical values in order to accept or reject the components as a function of this comparison. He doesn't provide what specific components are to be tested. It would have been obvious to one having ordinary skill in the art to employ such a testing methodology in the selection process of Sato, such as is taught by Lejeune, at the time of the Sato invention in order to prevent components which fail quality testing from being provided to users.

Moreover, such testing is typical in manufacturing and is a typical part of quality control, to employ such involves no inventive step.

Claims 4-6, 10-12, 16-18 and 22-24 are rejected under 35 U.S.C. 103(a) as being unpatentable over Sato et al. (US 5,424,602) and Lejeune (US 6,269,326) in view of Onishi et al. (JP 2000-216450). Given the combined invention of Sato et al. and Lejeune as noted above, it is not noted by them that they measure or determine the

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bandwidth of an input-impedance-versus-frequency characteristic of the piezoelectric transformer by subtracting a resonant-frequency fr from an anti-resonant frequency fa and selecting the characteristic of the piezoelectric transformer based on the value of the measured bandwidth. Onishi et al. note (see solution) a method for selecting a piezoelectric transformer characteristic, comprising the steps of: connecting (e.g. see fig. 1) a primary-side driving section of a piezoelectric transformer (2) to a highfrequency generator (E); causing said high-frequency generator to sequentially generate and sweep a high-frequency signal over a predetermined frequency range: measuring a resonant frequency (fr) or a resonant resistance (see |Y| of gig. 2 which is inverse of impedance) or both of an input-impedance-versus-frequency characteristic of the piezoelectric transformer (2); they measure or determine the bandwidth of an inputimpedance-versus-frequency characteristic of the piezoelectric transformer by substracting a resonant-frequency fr from an antiresonant-frequency fa and select the characteristic of the piezoelectric transformer based on the value of the measured bandwidth. The transformer in every figure is in an isolated state in which it is not mounted on a mounted substrate. Onishi's secondary-side generating section is not shown as being in an open state but is short circuited to ground through R1.

It would have been obvious to one having ordinary skill in the art to determine a characteristic of the piezoelectric transformer of Sato et al. and Lejeune, based on the value of the measured bandwidth, determined by substracting a resonant-frequency fr from an antiresonant-frequency fa, as is shown by Onishi, at the time of the Sato

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invention, since the "power conversion efficiency of a power conversion device is set to be maximum", as is noted by Onishi.

Claims 4-6, 10-12, 16-18 and 22-24 are rejected under 35 U.S.C. 103(a) as being unpatentable over Sato et al. (US 5,424,602) and Lejeune (US 6,269,326) in view of Kawada (US 3,778,648). Given the invention of Sato et al. and Lejeune as noted above, it is not noted by them that they measure or determine the bandwidth of an input-impedance-versus-frequency characteristic of the piezoelectric transformer by subtracting a resonant-frequency fr from an antiresonant-frequency fa and selecting the characteristic of the piezoelectric transformer, comprising the steps of: connecting a primary-side driving section of a piezoelectric transformer to a high-frequency generator; causing said high-frequency generator to sequentially generate and sweep a high-frequency signal over a predetermined frequency range; measuring a resonant frequency (fr) or a resonant resistance (see |Z|) or both of an input-impedance-versusfrequency characteristic of the piezoelectric transformer; he measures or determines the bandwidth of an input-impedance-versus-frequency characteristic of the piezoelectric transformer by subtracting a resonant-frequency fr from an antiresonant-frequency fa and select the characteristic of the piezoelectric transformer based on the value of the measured bandwidth, which is required for determination of his driving frequency. He doesn't note that the transformer is in an isolated state in which it is not mounted on a mounting substrate. It is not known if Kawada's secondary-side generating section is in an open state.

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It would have been obvious to one having ordinary skill in the art to determine a characteristic of the piezoelectric transformer of Sato et al. and Lejeune based on the value of the measured bandwidth, determined by subtracting a resonant-frequency fr from an antiresonant-frequency fa, as is shown by Kawada, at the time of the Sato invention, since "the power conversion efficiency of a power conversion device is set to be maximum", as has been noted.

Direct inquiry concerning this action to Examiner Dougherty at (571) 272-2022.

met tmd

April 23, 2004

THOMAS M. DUUCHEL Y PRIMARY EXAMINER